

<b>Notice of References Cited</b>	Application/Control No. 10/566,204		Applicant(s)/Patent Under Reexamination SUGIYAMA ET AL.	
	Examiner VICTORIA W. CHEN		Art Unit 3739	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,835,841 A	09-1974	Terada, Masaaki	600/157
*	B	US-4,616,631 A	10-1986	Takahashi, Nagashige	600/139
*	C	US-4,807,593 A	02-1989	Ito, Hideo	600/114
*	D	US-5,984,932 A	11-1999	Yoon, InBae	606/147
*	E	US-2001/0049509 A1	12-2001	Sekine et al.	600/104
*	F	US-6,352,503 B1	03-2002	Matsui et al.	600/104
*	G	US-6,440,061 B1	08-2002	Wenner et al.	600/114
*	H	US-2003/0100837 A1	05-2003	Lys et al.	600/476
*	I	US-2004/0138525 A1	07-2004	Saadat et al.	600/104
*	J	US-7,029,435 B2	04-2006	Nakao, Naomi L.	600/153
*	K	US-2006/0241347 A1	10-2006	Whitehead, Peter	600/146
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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